

Notice of References Cited	Application/Control No. 10/776,783	Applicant(s)/Patent Under Reexamination ASANO ET AL.	
	Examiner Binh X. Tran	Art Unit 1765	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0092102	05-2004	Li et al.	438/689
*	B	US-2002/0081949	06-2002	Yoshida et al.	451/41
*	C	US-5,229,258	07-1993	Sezi et al.	430/325
*	D	US-4,743,418	05-1988	Barnes et al.	264/48
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
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	T					

NON-PATENT DOCUMENTS

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	V	
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